

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10501877	MIYAMOTO ET AL.
	Examiner	Art Unit
	Wendimagegn, Girumsew	2621

SEARCHED

Class	Subclass	Date	Examiner
386	52	9/11/2007	gw
386	64	9/11/2007	gw
386	95	9/11/2007	gw

SEARCH NOTES

Search Notes	Date	Examiner
US-PGPUB;USPAT;USOCR;EPO;JPO;DERWENT;IBM_TDB	9/11/2007	gw
Inventor(s) search	9/24/2007	gw
Consulted Thai Tran	9/11/2007	gw

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner